Search Notes

Application/Control N	lo.
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10/518,644 Examiner

Wayne Langel

Applicant(s)/Patent under Reexamination

KOMATSU ET AL.

Art Unit

1754 -

SEARCHED				
Class	Subclass	Date	Examiner	
204	157,41	8-3-07	WAL	
204	157.45	8-3-07 8-3-07	WAL	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Chemical Abotract Computer Sarch (of second in file)	8-3-07	WAL		
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